

**Search Notes**

Application/Control No.

10/664,329

Examiner

Dah-Wei D. Yuan

Applicant(s)/Patent under  
Reexamination

GOEBEL, STEVEN G.

Art Unit

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**SEARCHED**

Class	Subclass	Date	Examiner
429	13	4/28/2005	DWY
420	17	4/28/2005	DWY
420	30	4/28/2005	DWY

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
429	13	4/28/2005	DWY
429	17	4/28/2005	DWY
429	30	4/28/2005	DWY

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	4/28/2005	DWY
Inventorship Search	4/28/2005	DWY